

**Notice of References Cited**

Application/Control No.

09/884,313

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Yvette C. Thornton

Art Unit

1752

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0018960 A1	02-2002	Lee et al.	430/270.1
	B	US-6,303,725 B1	10-2001	Chang et al.	526/266
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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